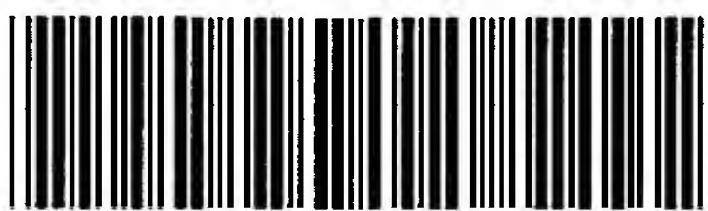


Search Notes**Application/Control No.**

10/709,379

Examiner

Leith A. Al-Nazer

Applicant(s)/Patent under Reexamination

HWANG ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	702	9/22/2005	LA
455	90.3	9/22/2005	LA
455	550.1	9/22/2005	LA
455	575.1	9/22/2005	LA
455	575.3	9/22/2005	LA
455	575.4	9/22/2005	LA
455	575.7	9/22/2005	LA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
343	702	9/22/2005	LA
455	90.3	9/22/2005	LA
455	550.1	9/22/2005	LA
455/575.1, 575.3, 575.4, 575.7	9/22/2005	LA	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST prior art text search (see "Examiner Search Notes")	9/22/2005	LA
EAST interference text search (see "Examiner Search Notes")	9/22/2005	LA